

# APT30M30JFLL

300V 88A  $0.030\Omega$ 

# POWER MOS 7™



Power MOS  $7^{\text{TM}}$  is a new generation of low loss, high voltage, N-Channel enhancement mode power MOSFETS. Both conduction and switching losses are addressed with Power MOS  $7^{\text{TM}}$  by significantly lowering  $R_{\text{DS(ON)}}$  and  $Q_g$ . Power MOS  $7^{\text{TM}}$  combines lower conduction and switching losses along with exceptionally fast switching speeds inherent with APT's patented metal gate structure.

- Lower Input Capacitance
- Lower Miller Capacitance
- Lower Gate Charge, Qg
- Increased Power Dissipation
- Easier To Drive
- Popular SOT-227 Package
- FAST RECOVERY BODY DIODE





### **MAXIMUM RATINGS**

All Ratings:  $T_C = 25^{\circ}C$  unless otherwise specified.

Symbol	Parameter	APT30M30JFLL	UNIT	
V <sub>DSS</sub>	Drain-Source Voltage	300	Volts	
I <sub>D</sub>	Continuous Drain Current @ T <sub>C</sub> = 25°C	88	Amno	
I <sub>DM</sub>	Pulsed Drain Current ①	352	Amps	
V <sub>GS</sub>	Gate-Source Voltage Continuous	±30	Valta	
V <sub>GSM</sub>	Gate-Source Voltage Transient	±40	Volts	
P <sub>D</sub>	Total Power Dissipation @ T <sub>C</sub> = 25°C	520	Watts	
, D	Linear Derating Factor	4.16	W/°C	
$T_J$ , $T_{STG}$	Operating and Storage Junction Temperature Range	-55 to 150	°C	
T <sub>L</sub>	Lead Temperature: 0.063" from Case for 10 Sec.	300	] [	
I <sub>AR</sub>	Avalanche Current (Repetitive and Non-Repetitive)	88	Amps	
E <sub>AR</sub>	Repetitive Avalanche Energy ①	50	ml	
E <sub>AS</sub>	Single Pulse Avalanche Energy <sup>(4)</sup>	3000	mJ	

#### STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage $(V_{GS} = 0V, I_D = 250\mu\text{A})$	300			Volts
I <sub>D(on)</sub>	On State Drain Current ② $(V_{DS} > I_{D(on)} \times R_{DS(on)} Max, V_{GS} = 10V)$	88			Amps
R <sub>DS(on)</sub>	Drain-Source On-State Resistance ② (V <sub>GS</sub> = 10V, 0.5 I <sub>D[Cont.]</sub> )			0.036	Ohms
I <sub>DSS</sub>	Zero Gate Voltage Drain Current $(V_{DS} = V_{DSS}, V_{GS} = 0V)$			250	μА
	Zero Gate Voltage Drain Current $(V_{DS} = 0.8 V_{DSS}, V_{GS} = 0V, T_{C} = 125^{\circ}C)$			1000	
I <sub>GSS</sub>	Gate-Source Leakage Current (V <sub>GS</sub> = ±30V, V <sub>DS</sub> = 0V)			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage $(V_{DS} = V_{GS}, I_{D} = 2.5 \text{mA})$	3		5	Volts

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

APT Website - http://www.advancedpower.com

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Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
C <sub>iss</sub>	Input Capacitance	$V_{GS} = 0V$		7830		
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 25V		1870		pF
C <sub>rss</sub>	Reverse Transfer Capacitance	f = 1 MHz		89		
Qg	Total Gate Charge <sup>③</sup>	V <sub>GS</sub> = 10V		146		
Q <sub>gs</sub>	Gate-Source Charge	$V_{DD} = 0.5 V_{DSS}$		40		nC
Q <sub>gd</sub>	Gate-Drain ("Miller") Charge	I <sub>D</sub> = I <sub>D</sub> [Cont.] @ 25°C		56		
t <sub>d</sub> (on)	Turn-on Delay Time	V <sub>GS</sub> = 15V		15		
t <sub>r</sub>	Rise Time	$V_{DD} = 0.5 V_{DSS}$		22		
t <sub>d</sub> (off)	Turn-off Delay Time	I <sub>D</sub> = I <sub>D</sub> [Cont.] @ 25°C		35		ns
t <sub>f</sub>	Fall Time	$R_G = 0.6\Omega$		8		

## **SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS**

Symbol	Characteristic / Test Conditions		MIN	TYP	MAX	UNIT	
I <sub>S</sub>	Continuous Source Current (Body Diode)	CAL			88	A	
I <sub>SM</sub>	Pulsed Source Current (1) (Body Diode)		13		352	Amps	
V <sub>SD</sub>	Diode Forward Voltage $\bigcirc$ ( $V_{GS} = 0V$ , $I_{S} = -I_{D}$ [Cont.])	410			1.3	Volts	
dv/ <sub>dt</sub>	Peak Diode Recovery dv/ <sub>dt</sub> (5)	V			8	V/ns	
4	Reverse Recovery Time $(I_S = -I_D [Cont.], di/dt = 100A/\mu s)$	T <sub>j</sub> = 25°C		250			
t <sub>rr</sub>		T <sub>j</sub> = 125°C		500		ns	
	Reverse Recovery Charge	T <sub>j</sub> = 25°C		1.4			
Q <sub>rr</sub>	$(I_S = -I_D [Cont.], di/dt = 100A/\mu s)$	T <sub>j</sub> = 125°C		4.9		μC	
I <sub>RRM</sub>	Peak Recovery Current	T <sub>j</sub> = 25°C		14		A	
	$(I_S = -I_D [Cont.], \frac{di}{dt} = 100A/\mu s)$	T <sub>j</sub> = 125°C		25		Amps	

## THERMAL CHARACTERISTICS

Symbol	Characteristic	MIN	TYP	MAX	UNIT
$R_{ heta JC}$	Junction to Case			0.24	
$R_{\theta JA}$	Junction to Ambient			40	°C/W

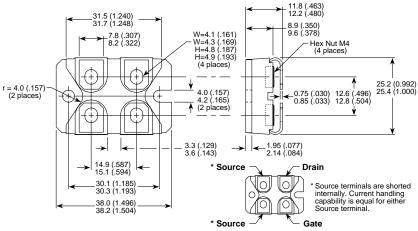
<sup>1</sup> Repetitive Rating: Pulse width limited by maximum junction temperature.

2 Pulse Test: Pulse width < 380 µs, Duty Cycle < 2%

4 Starting T<sub>i</sub> = +25°C, L = 0.77mH, R<sub>G</sub> = 25 $\Omega$ , Peak I<sub>L</sub> = 88A

(5) dv/<sub>dt</sub> numbers reflect the limitations of the test circuit rather than the device itself.  $I_S \le -I_{D[Cont.]}$  di/dt  $\le 700 \text{A}/\mu \text{s}$   $V_R \le V_{DSS}$   $T_J \le 150 ^{\circ} \text{C}$  APT Reserves the right to change, without notice, the specifications and information contained herein.

# SOT-227 (ISOTOP®) Package Outline



Dimensions in Millimeters and (Inches)

③ See MIL-STD-750 Method 3471